

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/533,074	JIN, BENYOU	
Examiner			Art Unit	2861	Page 1 of 1
Henok Legesse					

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,954,149 A	09-1990	Fullemann, James S.	96/105
*	B	US-6,045,207 A	04-2000	Mochizuki et al.	347/7
*	C	US-2004/0001127 A1	01-2004	Nip, Shui Kuen	347/86
*	D	US-6,702,434 B2	03-2004	Barinaga et al.	347/85
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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